Data sheet acquired from Harris Semiconductor SCHS245B

## Features

- Buffered Inputs
- Typical Propagation Delay
- 4ns at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$
- Exceeds 2kV ESD Protection per MIL-STD-883, Method 3015
- SCR-Latchup-Resistant CMOS Process and Circuit Design
- Speed of Bipolar FAST™/AS/S with Significantly Reduced Power Consumption
- Balanced Propagation Delays
- AC Types Feature 1.5V to 5.5V Operation and Balanced Noise Immunity at 30\% of the Supply
- $\pm 24 m A$ Output Drive Current
- Fanout to 15 FAST ${ }^{\text {TM }}$ ICs
- Drives $50 \Omega$ Transmission Lines


## Description

The 'AC245 and 'ACT245 are octal-bus transceivers that utilize Advanced CMOS Logic technology. They are noninverting three-state bidirectional transceiver-buffers intended for two-way transmission from "A" bus to "B" bus or " $B$ " bus to " $A$ ". The logic level present on the direction input (DIR) determines the data direction. When the output enable input ( $\overline{\mathrm{OE}}$ ) is HIGH, the outputs are in the high-impedance state.

## Ordering Information

| PART <br> NUMBER | TEMP. <br> RANGE ${ }^{\circ} \mathrm{C}$ ) | PACKAGE |
| :--- | :--- | :--- |
| CD54AC245F3A | -55 to 125 | 20 Ld CERDIP |
| CD74AC245E | -55 to 125 | 20 Ld PDIP |
| CD74AC245M | -55 to 125 | 20 Ld SOIC |
| CD74AC245SM | -55 to 125 | 20 Ld SSOP |
| CD54ACT245F3A | -55 to 125 | 20 Ld CERDIP |
| CD74ACT245E | -55 to 125 | 20 Ld PDIP |
| CD74ACT245M | -55 to 125 | 20 Ld SOIC |
| CD74ACT245SM | -55 to 125 | 20 Ld SSOP |
| NOTES: |  |  |

1. When ordering, use the entire part number. Add the suffix 96 to obtain the variant in the tape and reel.
2. Wafer and die for this part number is available which meets all electrical specifications. Please contact your local TI sales office or customer service for ordering information.

## Pinout

| DIR 1 | 20 VCC |
| :---: | :---: |
| A0 2 | 19 OE |
| A1 3 | 18 B0 |
| A2 4 | $17 \mathrm{B1}$ |
| A3 5 | 16 B2 |
| A4 6 | 15 B3 |
| A5 7 | 14 B4 |
| A6 8 | $13 \mathrm{B5}$ |
| A7 9 | $12 \mathrm{B6}$ |
| GND 10 | 11 B7 |

## Functional Diagram



TRUTH TABLE

| CONTROL INPUTS |  | OPERATION |
| :---: | :---: | :--- |
| $\overline{\mathrm{OE}}$ | DIR |  |
| L | L | B Data to A Bus |
| L | H | A Data to B Bus |
| H | X | Isolation |

$\mathrm{H}=$ High Level, $\mathrm{L}=$ Low Level, $\mathrm{X}=$ Irrelevant
To prevent excess currents in the High-Z (isolation) modes, all I/O terminals should be terminated with $10 \mathrm{k} \Omega$ to $1 \mathrm{M} \Omega$ resistors.

| Absolute Maximum Ratings |  |
| :---: | :---: |
| DC Supply Voltage, $\mathrm{V}_{\mathrm{CC}}$ | -0.5V to 6V |
| DC Input Diode Current, $\mathrm{I}_{\mathrm{K}}$ |  |
| For $\mathrm{V}_{1}<-0.5 \mathrm{~V}$ or $\mathrm{V}_{1}>\mathrm{V}_{\mathrm{CC}}+0.5 \mathrm{~V}$ | $\pm 20 \mathrm{~mA}$ |
| DC Output Diode Current, IOK |  |
| For $\mathrm{V}_{\mathrm{O}}<-0.5 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{O}}>\mathrm{V}_{\mathrm{CC}}+0.5 \mathrm{~V}$ | $\pm 50 \mathrm{~mA}$ |
| DC Output Source or Sink Current per Output Pin, Io |  |
| DC $\mathrm{V}_{\text {CC }}$ or Ground Current, ICC or $\mathrm{I}_{\text {GND }}$ (Note 3) | $\pm 100 \mathrm{~mA}$ |
| Operating Conditions |  |
|  | ${ }^{-55}{ }^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ |
| Supply Voltage Range, $\mathrm{V}_{\text {CC }}$ (Note 4) |  |
| AC Types. | .1.5V to 5.5 V |
| ACT Types | .4.5V to 5.5V |
| DC Input or Output Voltage, $\mathrm{V}_{\mathrm{I}}, \mathrm{V}_{\mathrm{O}} \ldots \ldots . . . . . . . . . . . . \mathrm{VV}$ to $\mathrm{V}_{\mathrm{CC}}$ |  |
|  |  |
| AC Types, 1.5 V to 3 V | 50ns (Max) |
| AC Types, 3.6 V to 5.5 V . | 20ns (Max) |
| ACT Types, 4.5 V to 5.5 V . | 10ns (Max) |

## Thermal Information

Thermal Resistance (Typical, Note 5) $\quad \theta_{\mathrm{JA}}\left({ }^{\circ} \mathrm{C} / \mathrm{W}\right)$
E Package . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 69

M Package
58
SM Package
70
Maximum Junction Temperature (Plastic Package) . . . . . . . . . . 150 ${ }^{\circ} \mathrm{C}$
Maximum Storage Temperature Range . . . . . . . . . $-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$
Maximum Lead Temperature (Soldering 10s) . . . . . . . . . . . . . $300^{\circ} \mathrm{C}$

Operating Conditions
Temperature Range, $\mathrm{T}_{\mathrm{A}}$. . . . . . . . . . . . . . . . . . . . . . $-55^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## NOTES:

3. For up to 4 outputs per device, add $\pm 25 \mathrm{~mA}$ for each additional output.
4. Unless otherwise specified, all voltages are referenced to ground.
5. The package thermal impedance is calculated in accordance with JESD 51-7.

## DC Electrical Specifications

| PARAMETER | SYMBOL | TEST CONDITIONS |  | $\begin{aligned} & V_{\mathrm{Cc}} \\ & (\mathrm{~V}) \end{aligned}$ | $25^{\circ} \mathrm{C}$ |  | $\begin{gathered} -40^{\circ} \mathrm{C} \text { TO } \\ 85^{\circ} \mathrm{C} \end{gathered}$ |  | $\begin{gathered} -55^{\circ} \mathrm{C} \text { TO } \\ 125^{\circ} \mathrm{C} \end{gathered}$ |  | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{V}_{1}(\mathrm{~V})$ | 10 (mA) |  | MIN | MAX | MIN | MAX | MIN | MAX |  |

AC TYPES

| High Level Input Voltage | $\mathrm{V}_{\mathrm{IH}}$ | - | - | 1.5 | 1.2 | - | 1.2 | - | 1.2 | - | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | 3 | 2.1 | - | 2.1 | - | 2.1 | - | V |
|  |  |  |  | 5.5 | 3.85 | - | 3.85 | - | 3.85 | - | V |
| Low Level Input Voltage | VIL | - | - | 1.5 | - | 0.3 | - | 0.3 | - | 0.3 | V |
|  |  |  |  | 3 | - | 0.9 | - | 0.9 | - | 0.9 | V |
|  |  |  |  | 5.5 | - | 1.65 | - | 1.65 | - | 1.65 | V |
| High Level Output Voltage | $\mathrm{V}_{\mathrm{OH}}$ | $\mathrm{V}_{\mathrm{IH}}$ or $\mathrm{V}_{\mathrm{IL}}$ | -0.05 | 1.5 | 1.4 | - | 1.4 | - | 1.4 | - | V |
|  |  |  | -0.05 | 3 | 2.9 | - | 2.9 | - | 2.9 | - | V |
|  |  |  | -0.05 | 4.5 | 4.4 | - | 4.4 | - | 4.4 | - | V |
|  |  |  | -4 | 3 | 2.58 | - | 2.48 | - | 2.4 | - | V |
|  |  |  | -24 | 4.5 | 3.94 | - | 3.8 | - | 3.7 | - | V |
|  |  |  | $-75$ <br> (Note 6, 7) | 5.5 | - | - | 3.85 | - | - | - | V |
|  |  |  | -50 <br> (Note 6, 7) | 5.5 | - | - | - | - | 3.85 | - | V |

DC Electrical Specifications (Continued)

| PARAMETER | SYMBOL | TEST CONDITIONS |  | $\begin{aligned} & \mathrm{V}_{\mathrm{Cc}} \\ & (\mathrm{~V}) \end{aligned}$ | $25^{\circ} \mathrm{C}$ |  | $\begin{gathered} -40^{\circ} \mathrm{C} \text { TO } \\ 85^{\circ} \mathrm{C} \end{gathered}$ |  | $\begin{gathered} -55^{\circ} \mathrm{C} \text { TO } \\ 125^{\circ} \mathrm{C} \end{gathered}$ |  | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{V}_{1}(\mathrm{~V})$ | $\mathrm{I}_{0}(\mathrm{~mA})$ |  | MIN | MAX | MIN | MAX | MIN | MAX |  |
| Low Level Output Voltage | $\mathrm{V}_{\mathrm{OL}}$ | $\mathrm{V}_{\mathrm{IH}}$ or $\mathrm{V}_{\mathrm{IL}}$ | 0.05 | 1.5 | - | 0.1 | - | 0.1 | - | 0.1 | V |
|  |  |  | 0.05 | 3 | - | 0.1 | - | 0.1 | - | 0.1 | V |
|  |  |  | 0.05 | 4.5 | - | 0.1 | - | 0.1 | - | 0.1 | V |
|  |  |  | 12 | 3 | - | 0.36 | - | 0.44 | - | 0.5 | V |
|  |  |  | 24 | 4.5 | - | 0.36 | - | 0.44 | - | 0.5 | V |
|  |  |  | $\begin{gathered} 75 \\ (\text { Note 6, 7) } \end{gathered}$ | 5.5 | - | - | - | 1.65 | - | - | V |
|  |  |  | $\begin{gathered} 50 \\ \text { (Note 6, 7) } \end{gathered}$ | 5.5 | - | - | - | - | - | 1.65 | V |
| Input Leakage Current | 1 | $\begin{aligned} & \hline \mathrm{V}_{\mathrm{CC}} \text { or } \\ & \mathrm{GND} \end{aligned}$ | - | 5.5 | - | $\pm 0.1$ | - | $\pm 1$ | - | $\pm 1$ | $\mu \mathrm{A}$ |
| Three-State Leakage Current | loz | $\begin{aligned} & \mathrm{V}_{\mathrm{IH}} \text { or } \mathrm{V}_{\mathrm{IL}} \\ & \mathrm{~V}_{\mathrm{O}}=\mathrm{V}_{\mathrm{CC}} \\ & \text { or } G N D \end{aligned}$ | - | 5.5 | - | $\pm 0.5$ | - | $\pm 5$ | - | $\pm 10$ | $\mu \mathrm{A}$ |
| Quiescent Supply Current MSI | ${ }^{\text {c C }}$ | $\mathrm{V}_{\mathrm{CC}} \text { or }$ GND | 0 | 5.5 | - | 8 | - | 80 | - | 160 | $\mu \mathrm{A}$ |

ACT TYPES

| High Level Input Voltage | $\mathrm{V}_{\mathrm{IH}}$ | - | - | $\begin{gathered} 4.5 \text { to } \\ 5.5 \end{gathered}$ | 2 | - | 2 | - | 2 | - | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Low Level Input Voltage | $\mathrm{V}_{\text {IL }}$ | - | - | $\begin{gathered} 4.5 \text { to } \\ 5.5 \end{gathered}$ | - | 0.8 | - | 0.8 | - | 0.8 | V |
| High Level Output Voltage | $\mathrm{V}_{\mathrm{OH}}$ | $\mathrm{V}_{\text {IH }}$ or $\mathrm{V}_{\text {IL }}$ | -0.05 | 4.5 | 4.4 | - | 4.4 | - | 4.4 | - | V |
|  |  |  | -24 | 4.5 | 3.94 | - | 3.8 | - | 3.7 | - | V |
|  |  |  | $\begin{gathered} -75 \\ (\text { Note } 6,7) \end{gathered}$ | 5.5 | - | - | 3.85 | - | - | - | V |
|  |  |  | (Note 6, 7) | 5.5 | - | - | - | - | 3.85 | - | V |
| Low Level Output Voltage | $\mathrm{V}_{\mathrm{OL}}$ | $\mathrm{V}_{\text {IH }}$ or $\mathrm{V}_{\text {IL }}$ | 0.05 | 4.5 | - | 0.1 | - | 0.1 | - | 0.1 | V |
|  |  |  | 24 | 4.5 | - | 0.36 | - | 0.44 | - | 0.5 | V |
|  |  |  | $\begin{gathered} 75 \\ \text { (Note 6, 7) } \end{gathered}$ | 5.5 | - | - | - | 1.65 | - | - | V |
|  |  |  | 50 (Note 6, 7) | 5.5 | - | - | - | - | - | 1.65 | V |
| Input Leakage Current | I | $\begin{gathered} \mathrm{V}_{\mathrm{CC}} \text { or } \\ \mathrm{GND} \end{gathered}$ | - | 5.5 | - | $\pm 0.1$ | - | $\pm 1$ | - | $\pm 1$ | $\mu \mathrm{A}$ |
| Three-State or Leakage Current | l OZ | $\begin{gathered} \mathrm{V}_{\mathrm{IH}} \text { or } \mathrm{V}_{\mathrm{IL}} \\ \mathrm{~V}_{\mathrm{O}}=\mathrm{V}_{\mathrm{CC}} \\ \text { or } \mathrm{GND} \end{gathered}$ | - | 5.5 | - | $\pm 0.5$ | - | $\pm 5$ | - | $\pm 10$ | $\mu \mathrm{A}$ |
| Quiescent Supply Current MSI | $I_{\text {CC }}$ | $V_{C C} \text { or }$ GND | 0 | 5.5 | - | 8 | - | 80 | - | 160 | $\mu \mathrm{A}$ |
| Additional Supply Current per Input Pin TTL Inputs High 1 Unit Load | $\Delta^{\text {CC }}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}} \\ & -2.1 \end{aligned}$ | - | $\begin{gathered} 4.5 \text { to } \\ 5.5 \end{gathered}$ | - | 2.4 | - | 2.8 | - | 3 | mA |

NOTES:
6. Test one output at a time for a 1 -second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation.
7. Test verifies a minimum $50 \Omega$ transmission-line-drive capability at $85^{\circ} \mathrm{C}, 75 \Omega$ at $125^{\circ} \mathrm{C}$.

ACT Input Load Table

| INPUT | UNIT LOAD |
| :---: | :---: |
| $\mathrm{An}, \mathrm{Bn}$ | 0.83 |
| $\overline{\mathrm{OE}}$ | 0.64 |
| DIR | 0.25 |

NOTE: Unit load is $\Delta \mathrm{I}_{\mathrm{CC}}$ limit specified in DC Electrical Specifications Table, e.g., 2.4mA max at $25^{\circ} \mathrm{C}$.

Switching Specifications Input $t_{r}, t_{f}=3 n s, C_{L}=50 p F$ (Worst Case)

| PARAMETER | SYMBOL | $\mathrm{V}_{\mathrm{cc}}(\mathrm{V})$ | $-40^{\circ} \mathrm{C}$ TO $85{ }^{\circ} \mathrm{C}$ |  |  | ${ }_{-55}{ }^{\circ} \mathrm{C}$ TO $125^{\circ} \mathrm{C}$ |  |  | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | TYP | MAX | MIN | TYP | MAX |  |
| AC TYPES |  |  |  |  |  |  |  |  |  |
| Propagation Delay, Data to Output | ${ }_{\text {t }}$ PLH, $\mathrm{t}_{\text {PHL }}$ | 1.5 | - | - | 96 | - | - | 106 | ns |
|  |  | $\begin{gathered} 3.3 \\ \text { (Note 9) } \end{gathered}$ | 3.2 | - | 10.8 | 3 | - | 11.9 | ns |
|  |  | $\begin{gathered} 5 \\ (\text { Note 10) } \end{gathered}$ | 2.2 | - | 7.7 | 2.1 | - | 8.5 | ns |
| Propagation Delay, Output Disable to Output | tPLZ, tPHZ | 1.5 | - | - | 159 | - | - | 175 | ns |
|  |  | 3.3 | 4.7 | - | 15.9 | 4.4 | - | 17.5 | ns |
|  |  | 5 | 3.7 | - | 12.7 | 3.5 | - | 14 | ns |
| Propagation Delay, Output Enable to Output | ${ }_{\text {tPZL, }}$ tPZH | 1.5 | - | - | 159 | - | - | 175 | ns |
|  |  | 3.3 | 5.6 | - | 19 | 5.3 | - | 21 | ns |
|  |  | 5 | 3.7 | - | 12.7 | 3.5 | - | 14 | ns |
| Minimum (Valley) $\mathrm{V}_{\mathrm{OH}}$ During Switching of Other Outputs (Output Under Test Not Switching) | VOHV <br> See Figure 1 | 5 | - | $\begin{gathered} 4 \text { at } \\ 25^{\circ} \mathrm{C} \end{gathered}$ | - | - | $\begin{gathered} 4 \text { at } \\ 25^{\circ} \mathrm{C} \end{gathered}$ | - | V |
| Maximum (Peak) $\mathrm{V}_{\mathrm{OL}}$ During Switching of Other Outputs (Output Under Test Not Switching) | $V_{\text {OLP }}$ See Figure 1 | 5 | - | $\begin{array}{r} 1 \text { at } \\ 25^{\circ} \mathrm{C} \end{array}$ | - | - | $\begin{array}{r} 1 \text { at } \\ 25^{\circ} \mathrm{C} \end{array}$ | - | V |
| Three-State Output Capacitance | $\mathrm{Co}_{0}$ | - | - | 15 | - | - | 15 | - | pF |
| Input Capacitance | $\mathrm{C}_{1}$ | - | - | - | 10 | - | - | 10 | pF |
| Power Dissipation Capacitance | $\begin{aligned} & \text { CPD }^{2} \\ & \text { (Note 11) } \end{aligned}$ | - | - | 57 | - | - | 57 | - | pF |
| ACT TYPES |  |  |  |  |  |  |  |  |  |
| Propagation Delay, Data to Output | ${ }^{\text {tPLH }}$, tPHL | $\begin{gathered} 5 \\ (\text { Note 10) } \end{gathered}$ | 2.7 | - | 9.1 | 2.5 | - | 10 | ns |
| Propagation Delay, Output Disable to Output | ${ }_{\text {tPLZ }}$, tPHZ | 5 | 3.7 |  | 12.7 | 3.5 |  | 14 | ns |
| Propagation Delay, Output Enable to Output | ${ }_{\text {tPZL, }}$ tPZH | 5 | 3.8 |  | 13.1 | 3.6 |  | 14.4 | ns |
| Minimum (Valley) $\mathrm{V}_{\mathrm{OH}}$ During Switching of Other Outputs (Output Under Test Not Switching) | $V_{\mathrm{OHV}}$ <br> See Figure 1 | 5 | - | $\begin{gathered} 4 \text { at } \\ 25^{\circ} \mathrm{C} \end{gathered}$ | - | - | $\begin{gathered} 4 \text { at } \\ 25^{\circ} \mathrm{C} \end{gathered}$ | - | V |
| Maximum (Peak) $V_{\text {OL }}$ During Switching of Other Outputs (Output Under Test Not Switching) | $V_{\text {OLP }}$ See Figure 1 | 5 | - | $\begin{gathered} 1 \text { at } \\ 25^{\circ} \mathrm{C} \end{gathered}$ | - | - | $\begin{array}{r} 1 \text { at } \\ 25^{\circ} \mathrm{C} \end{array}$ | - | V |

Switching Specifications Input $t_{r}, t_{f}=3 n s, C_{L}=50 p F$ (Worst Case) (Continued)

| PARAMETER | SYMBOL | $\mathrm{V}_{\mathrm{cc}}(\mathrm{V})$ | $-40^{\circ} \mathrm{C}$ TO $85{ }^{\circ} \mathrm{C}$ |  |  | $-55^{\circ} \mathrm{C}$ TO $125^{\circ} \mathrm{C}$ |  |  | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | TYP | MAX | MIN | TYP | MAX |  |
| Three-State Output Capacitance | $\mathrm{C}_{\mathrm{O}}$ | - | - | 15 | - | - | 15 | - | pF |
| Input Capacitance | CI | - | - | - | 10 | - | - | 10 | pF |
| Power Dissipation Capacitance | $\begin{gathered} \mathrm{C}_{\text {PD }} \\ \text { (Note 11) } \end{gathered}$ | - | - | 57 | - | - | 57 | - | pF |

NOTES:
8. Limits tested $100 \%$
9. 3.3 V Min is at 3.6 V , Max is at 3 V .
10. 5 V Min is at 5.5 V , Max is at 4.5 V .
11. $\mathrm{C}_{\text {PD }}$ is used to determine the dynamic power consumption per channel.
$A C: P_{D}=V_{C C}{ }^{2} f_{i}\left(C_{P D}+C_{L}\right)$
$A C T: P_{D}=V_{C C}{ }^{2} f_{i}\left(C_{P D}+C_{L}\right)+V_{C C} \Delta I_{C C}$ where $f_{i}=$ input frequency, $C_{L}=$ output load capacitance, $V_{C C}=$ supply voltage.


NOTES:
12. Input pulses have the following characteristics: $\mathrm{PRR} \leq 1 \mathrm{MHz}, \mathrm{t}_{\mathrm{r}}=3 \mathrm{~ns}$, SKEW 1 ns .
13. R.F. fixture with 700 MHz design rules required. IC should be soldered into test board and bypassed with $0.1 \mu \mathrm{~F}$ capacitor. Scope and probes require 700 MHz bandwidth.

FIGURE 1. SIMULTANEOUS SWITCHING TRANSIENT WAVEFORMS


NOTE:
14. For $A C$ Series only: When $V_{C C}=1.5 \mathrm{~V}, R_{L}=1 \mathrm{k} \Omega$.

FIGURE 2. THREE-STATE PROPAGATION DELAY TIMES AND TEST CIRCUIT


FIGURE 3. PROPAGATION DELAY TIMES


NOTE: For $A C$ Series Only: When $V_{C C}=1.5 \mathrm{~V}, R_{L}=1 \mathrm{k} \Omega$.

|  | AC | ACT |
| :--- | :---: | :---: |
| Input Level | $\mathrm{V}_{\mathrm{CC}}$ | 3 V |
| Input Switching Voltage, $\mathrm{V}_{\mathrm{S}}$ | $0.5 \mathrm{~V}_{\mathrm{CC}}$ | 1.5 V |
| Output Switching Voltage, $\mathrm{V}_{\mathrm{S}}$ | $0.5 \mathrm{~V}_{\mathrm{CC}}$ | $0.5 \mathrm{~V}_{\mathrm{CC}}$ |

FIGURE 4. PROPAGATION DELAY TIMES

Texas Instruments

## PACKAGING INFORMATION

| Orderable Device | Status <br> (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <br> (2) | Lead finish/ Ball material <br> (6) | MSL Peak Temp <br> (3) | Op Temp ( ${ }^{\circ} \mathrm{C}$ ) | Device Marking <br> (4/5) | Samples |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CD54AC245F3A | ACTIVE | CDIP | J | 20 | 1 | Non-RoHS \& Green | SNPB | N/A for Pkg Type | -55 to 125 | CD54AC245F3A | Samples |
| CD54ACT245F3A | ACTIVE | CDIP | J | 20 | 1 | Non-RoHS \& Green | SNPB | N / A for Pkg Type | -55 to 125 | CD54ACT245F3A | Samples |
| CD74AC245E | ACTIVE | PDIP | N | 20 | 20 | RoHS \& Green | NIPDAU | N / A for Pkg Type | -55 to 125 | CD74AC245E | Samples |
| CD74AC245EE4 | ACTIVE | PDIP | N | 20 | 20 | RoHS \& Green | NIPDAU | N / A for Pkg Type | -55 to 125 | CD74AC245E | Samples |
| CD74AC245M | ACTIVE | SOIC | DW | 20 | 25 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | AC245M | Samples |
| CD74AC245M96 | ACTIVE | SOIC | DW | 20 | 2000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | AC245M | Samples |
| CD74ACT245E | ACTIVE | PDIP | N | 20 | 20 | RoHS \& Green | NIPDAU | N / A for Pkg Type | -55 to 125 | CD74ACT245E | Samples |
| CD74ACT245EE4 | ACTIVE | PDIP | N | 20 | 20 | RoHS \& Green | NIPDAU | N/ A for Pkg Type | -55 to 125 | CD74ACT245E | Samples |
| CD74ACT245M | ACTIVE | SOIC | DW | 20 | 25 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | ACT245M | Samples |
| CD74ACT245M96 | ACTIVE | SOIC | DW | 20 | 2000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | ACT245M | Samples |
| CD74ACT245M96G4 | ACTIVE | SOIC | DW | 20 | 2000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | ACT245M | Samples |
| CD74ACT245MG4 | ACTIVE | SOIC | DW | 20 | 25 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | ACT245M | Samples |
| CD74ACT245SM96 | ACTIVE | SSOP | DB | 20 | 2000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | ACT245SM | Samples |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.
${ }^{(2)}$ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.
${ }^{(3)}$ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
${ }^{(4)}$ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
${ }^{(5)}$ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
${ }^{(6)}$ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width

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OTHER QUALIFIED VERSIONS OF CD54AC245, CD54ACT245, CD74AC245, CD74ACT245 :

- Catalog : CD74AC245, CD74ACT245
- Military : CD54AC245, CD54ACT245

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Military - QML certified for Military and Defense Applications


## TAPE AND REEL INFORMATION


*All dimensions are nominal

| Device | Package <br> Type | Package <br> Drawing | Pins | SPQ | Reel <br> Diameter <br> $(\mathbf{m m})$ | Reel <br> Width <br> W1 $(\mathbf{m m})$ | A0 <br> $(\mathbf{m m})$ | B0 <br> $(\mathbf{m m})$ | K0 <br> $(\mathbf{m m})$ | P1 <br> $(\mathbf{m m})$ | W <br> $(\mathbf{m m})$ | Pin1 <br> Quadrant |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CD74AC245M96 | SOIC | DW | 20 | 2000 | 330.0 | 24.4 | 10.8 | 13.3 | 2.7 | 12.0 | 24.0 | Q1 |
| CD74ACT245M96 | SOIC | DW | 20 | 2000 | 330.0 | 24.4 | 10.8 | 13.3 | 2.7 | 12.0 | 24.0 | Q1 |
| CD74ACT245SM96 | SSOP | DB | 20 | 2000 | 330.0 | 16.4 | 8.2 | 7.5 | 2.5 | 12.0 | 16.0 | Q1 |


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CD74AC245M96 | SOIC | DW | 20 | 2000 | 367.0 | 367.0 | 45.0 |
| CD74ACT245M96 | SOIC | DW | 20 | 2000 | 367.0 | 367.0 | 45.0 |
| CD74ACT245SM96 | SSOP | DB | 20 | 2000 | 853.0 | 449.0 | 35.0 |



NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-150.


NOTES: (continued)
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.


SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL SCALE: 10X

NOTES: (continued)
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.


| DIM PINS ** | 14 | 16 | 18 | 20 |
| :---: | :---: | :---: | :---: | :---: |
| A | 0.300 <br> $(7,62)$ <br> BSC | 0.300 <br> $(7,62)$ <br> BSC | 0.300 <br> $(7,62)$ <br> BSC | 0.300 <br> $(7,62)$ <br> BSC |
| B MAX | 0.785 <br> $(19,94)$ | .840 <br> $(21,34)$ | 0.960 <br> $(24,38)$ | 1.060 <br> $(26,92)$ |
| B MIN | - | - | - | - |
| C MAX | 0.300 <br> $(7,62)$ | 0.300 <br> $(7,62)$ | 0.310 <br> $(7,87)$ | 0.300 <br> $(7,62)$ |
| C MIN | 0.245 <br> $(6,22)$ | 0.245 <br> $(6,22)$ | 0.220 <br> $(5,59)$ | 0.245 <br> $(6,22)$ |



NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package is hermetically sealed with a ceramic lid using glass frit.
D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)
PLASTIC DUAL-IN-LINE PACKAGE
16 PINS SHOWN


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C) Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).

D The 20 pin end lead shoulder width is a vendor option, either half or full width.


NOTES:

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side
5. Reference JEDEC registration MS-013.


NOTES: (continued)
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.


SOLDER PASTE EXAMPLE BASED ON 0.125 mm THICK STENCIL

SCALE:6X

NOTES: (continued)
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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